

FORM HDP-1449 (Based on Form PTO-1449)

ATTORNEY DOCKET NO.

SERIAL NO.

0315-000414/REF

10/678,052

PATENT AND TRADEMARK OFFICE

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Mark Bass et al.

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U.S. PATENT DOCUMENTS

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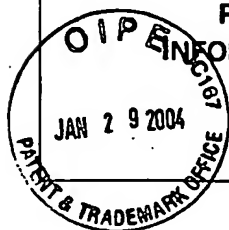
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